

**Search Notes****Application/Control No.**

10/720,311

**Examiner**

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**Applicant(s)/Patent under Reexamination**

SUN ET AL.

**Art Unit**

1765

**SEARCHED**

Class	Subclass	Date	Examiner
438	243	8/23/2005	KCC
	244		
	245		
	700		
	702		
	703		
	704		
	706		
	712		
438	719	8/23/05	KCC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East key words search USPT, USPT-pub. Epo, Jpo, IBM-TDB. Derwent.	8/23/2005	KCC
inventor search.	8/23/05	KCC